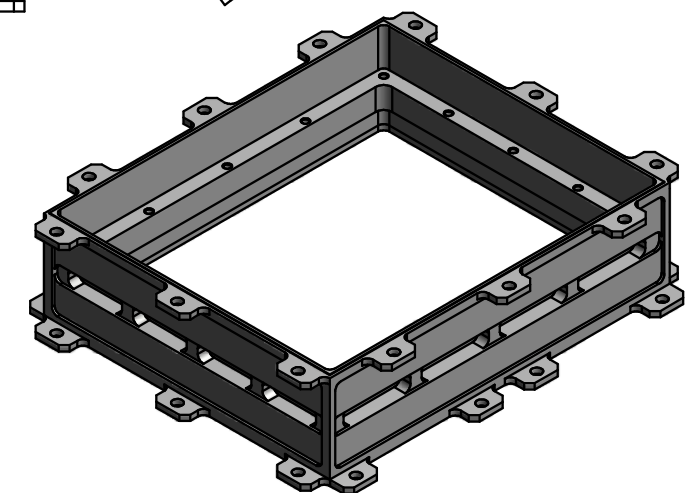
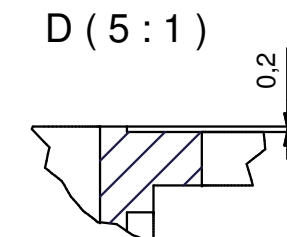
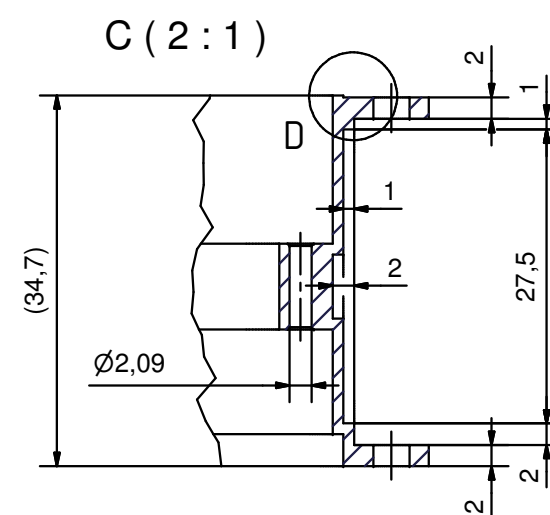
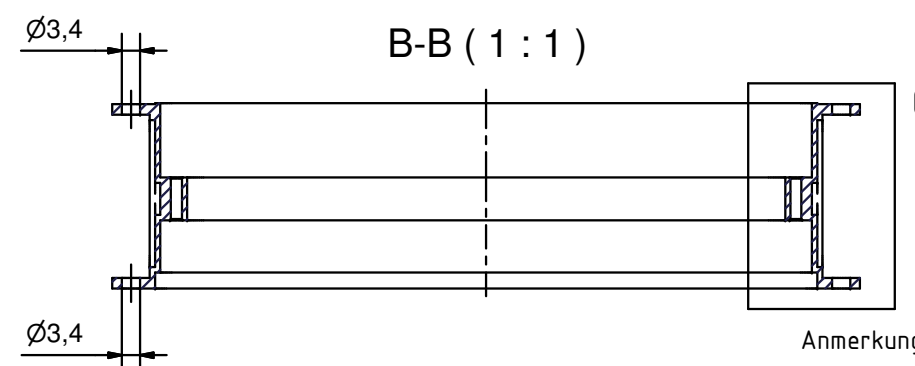
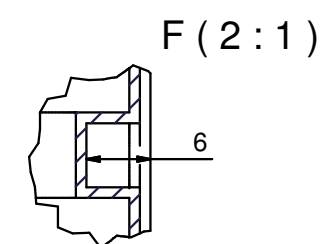
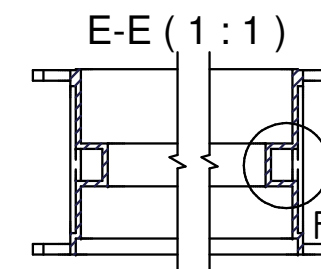
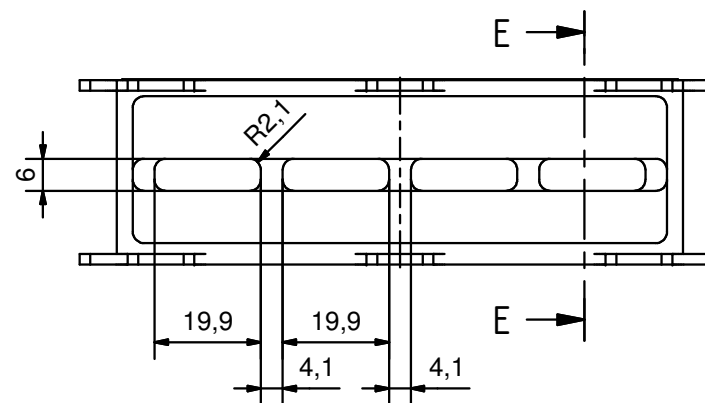
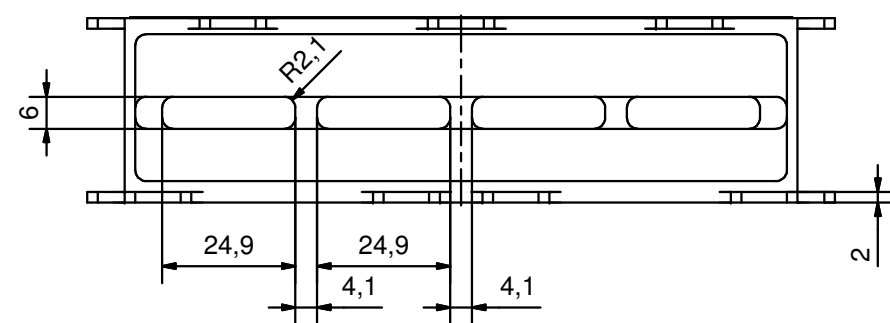
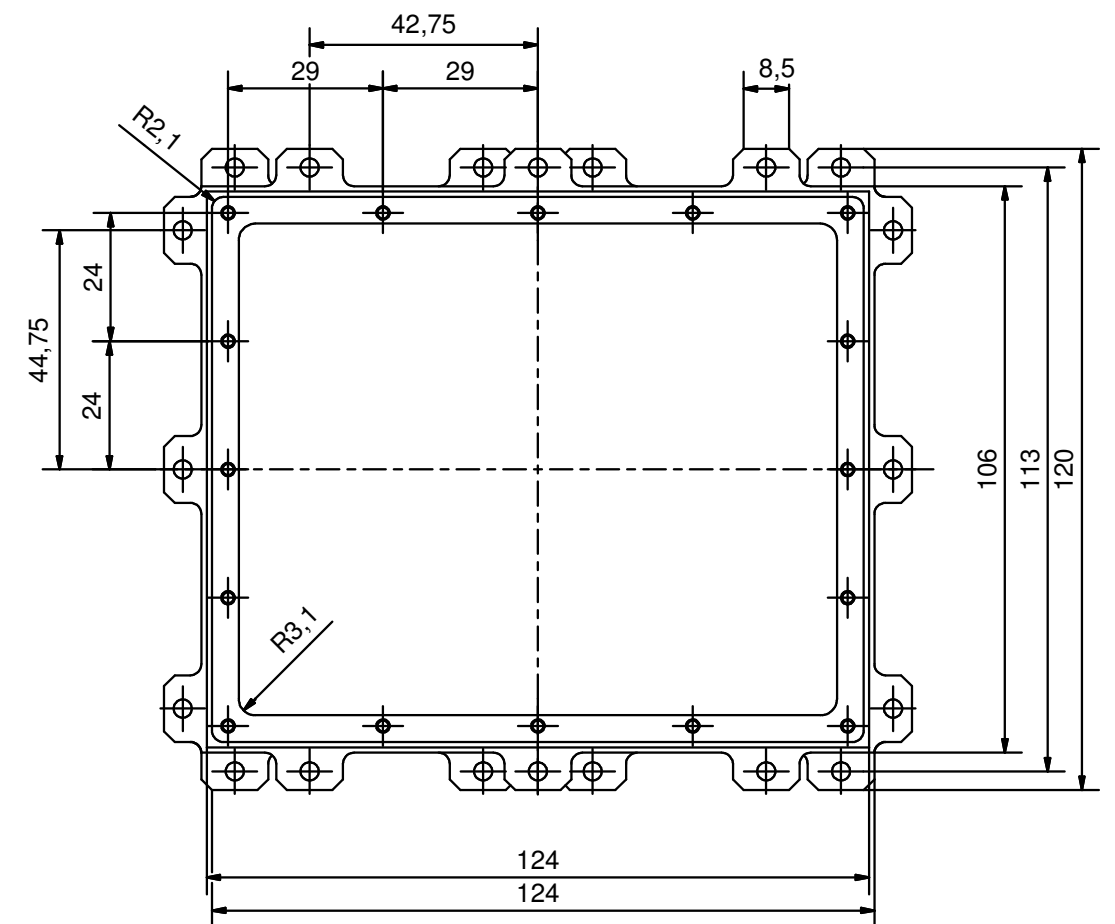
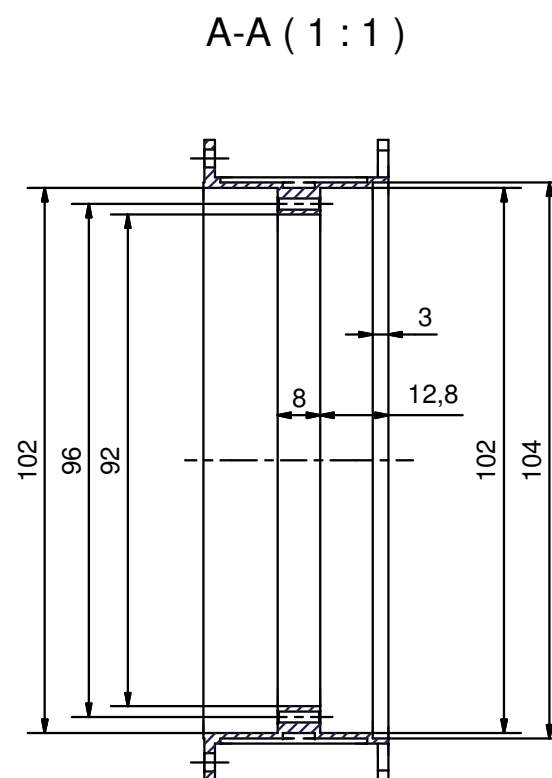
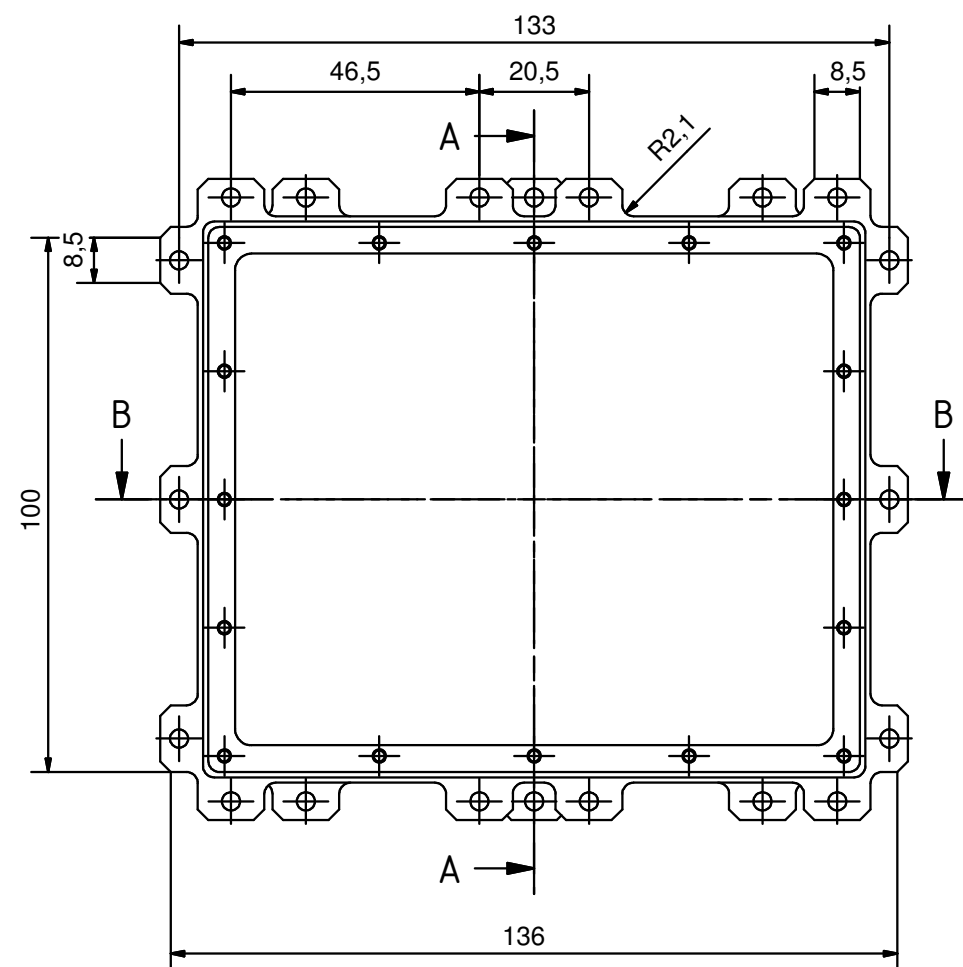
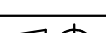




	Christian-Albrechts-Universität zu Kiel -IEAP- Institut für Experimentelle und Angewandte Physik		Allg. Toleranzen nach DIN 2768 Toleranzklasse: m		Oberfl., gow. n. in Zeich.:		Gewicht: 0,075 kg					
							3.3211/ AlMg1SiCu/ 6061					
							Date	Name	Zustand: InBearbeitung Status:			
							Drawn	16.05.2012				
		Checked										
		Standard										
							Projektion nach DIN 6-1 (E)		Seite: 1			
				so-epthet-c5_2215_data-module					von: 1			
				REV:					A2			
State	Changes	Date	Name									